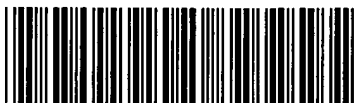


**Search Notes**

Application/Control No.

09/853,770

Examiner

Ellen C. Tran

Applicant(s)/Patent under  
Reexamination

SHIGEMATSU ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
713	186	12/21/2007	ET
726	9, 10	12/21/2007	ET
726	18, 19	12/21/2007	ET
726	20	12/21/2007	ET
713	185	12/21/2007	ET

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	12/21/2007	ET
NPL - IEEE XPLORE	12/21/2007	ET
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTIONS	12/21/2007	ET